Se	Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/618,257	WU ET AL.	
Examiner	Art Unit	
Mark Kopec	1751	

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Class	Subclass	Date	Examiner
252	500	1/18/2006	M.K.
252	511		
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204	450		
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INT	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
DATE	EXMR	
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